2-Propanol CMOS

(iso-propyl alcohol)



Material No.: 9079-05 Batch No.: 0000187111 Manufactured Date: 2017/10/16

Retest Date: 2022/10/15

Certificate of Analysis

10 ppm s Test .05 % 0.2 0.1 1 ppm 3 ppm <	00.0 5 < 4 PT 0.01 0.1 < 0.1 < 0.1 < 0.3
ppm s Test .05 % (0.2 0.1 < 1 ppm	< 4 PT 0.01 0.1 < 0.1 < 0.1
s Test .05 % 0 0.2 0.1 < 1 ppm	PT 0.01 0.1 < 0.1 < 0.1
.05 % (0.2 (0.1 (1.2 (1.2 (1.2 (1.2 (1.2 (1.2 (1.2 (1	0.01 0.1 < 0.1 < 0.1
0.2 0.1 < 1 ppm < 3 ppm <	0.1 < 0.1 < 0.1
0.1	< 0.1 < 0.1
1 ppm	< 0.1
3 ppm <	
• •	< 0.3
.0 nnh <	
662	5.0
0 ppb	< 1
.0 ppb <	1.0
0.0 ppb <	1.0
0.0 ppb <	10.0
.0 ppb <	5.0
.0 ppb <	1.0
.0 ppb <	1.0
.0 ppb <	< 1.0
.0 ppb <	1.0
.0 ppb <	1.0
.0 ppb <	< 1.0
.0 ppb <	10.0
	5.0
.0 ppb <	< 10
	0 ppb

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Test	Specification	Result
Trace Impurities - Iron (Fe)	<= 50.0 ppb	< 1.0
Trace Impurities - Lead (Pb)	<= 20.0 ppb	< 10.0
Trace Impurities – Lithium (Li)	<= 50.0 ppb	< 1.0
Trace Impurities - Magnesium (Mg)	<= 20.0 ppb	< 1.0
Trace Impurities - Manganese (Mn)	<= 15.0 ppb	< 1.0
Trace Impurities - Molybdenum (Mo)	<= 100.0 ppb	< 5.0
Trace Impurities - Nickel (Ni)	<= 10.0 ppb	< 5.0
Trace Impurities - Niobium (Nb)	<= 100.0 ppb	< 1.0
Trace Impurities – Potassium (K)	<= 100.0 ppb	< 10.0
Trace Impurities - Silicon (Si)	<= 50.0 ppb	< 10.0
Trace Impurities - Silver (Ag)	<= 20.0 ppb	< 1.0
Trace Impurities - Sodium (Na)	<= 100.0 ppb	< 5.0
Trace Impurities - Strontium (Sr)	<= 20.0 ppb	< 1.0
Trace Impurities - Tantalum (Ta)	<= 100.0 ppb	< 5.0
Trace Impurities - Thallium (Tl)	<= 10.0 ppb	< 5.0
Trace Impurities - Tin (Sn)	<= 100.0 ppb	< 10.0
Trace Impurities - Titanium (Ti)	<= 20.0 ppb	< 1.0
Trace Impurities - Vanadium (V)	<= 100.0 ppb	< 1.0
Trace Impurities - Zinc (Zn)	<= 50.0 ppb	< 1.0
Trace Impurities - Zirconium (Zr)	<= 100.0 ppb	< 1.0
Particle Count - 0.2 µm and greater	<= 5000 par/ml	9
Particle Count - 0.3 µm and greater	<= 5000 par/ml	3
Particle Count - 0.5 µm and greater	<= 50 par/ml	1
Particle Count – 1.0 µm and greater	<= 8 par/ml	< 1

For Microelectronic Use

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
Paris, KY 9001:2008
Mexico City, Mexico 9001:2008
Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
Gliwice, Poland 9001:2008, 13485:2012
Selangor, Malaysia 9001:2008
Dehradun, India, 9001:2008, 14001:2004, 13485:2003
Mumbai, India, 9001:2008
Panoli, India 9001:2008

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Vice President Global Quality